


<b>Search Notes</b> 	<b>Application/Control No.</b> 10516334	<b>Applicant(s)/Patent Under Reexamination</b> HOPKINS ET AL.
	<b>Examiner</b> Lee, Shun	<b>Art Unit</b> 2884

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
250	345	6/14/2007	/SL/

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	6/14/2007	/SL/

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>